



INFORMATION  
DISCLOSURE CITATION

ATTY DOCKET NO.  
6015.103US

SERIAL NO.  
10/008,594

FILING  
11/08/2001

GROUP  
To be assigned

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>Y</i>	3,834,786	10/10/1974	Carlsen	350	3.5	
<i>Y</i>	4,526,443	07/02/1985	Hirose	350	415	
<i>Y</i>	5,153,926	12/05/1989	Jansson, et al.	382	128	
<i>Y</i>	4,981,352	01/01/1991	Tejima, et al.	353	31	
<i>Y</i>	5,046,110	09/03/1991	Carucci, et al.	382	8	
<i>Y</i>	5,095,387	03/10/1992	Horiuchi	359	676	
<i>Y</i>	5,568,531	10/22/1996	Nishihagi, et al.	378	71	
<i>Y</i>	5,633,755	05/27/1997	Manabe, et al.	359	443	
<i>Y</i>	5,774,268	06/30/1998	Takahashi	359	630	
<i>Y</i>	5,802,408	09/01/1998	Suda	396	296	
<i>Y</i>	5,808,791	09/15/1998	Kawano, et al.	359	434	
<i>Y</i>	5,812,629	09/22/1998	Clauser	378	62	
<i>Y</i>	5,878,152	03/02/1999	Sussman	382	106	
<i>Y</i>	5,914,818	06/22/1999	Tejada, et al.	359	663	
<i>Y</i>	6,016,229	01/18/2000	Suzuki	359	784	

FOREIGN PATENT DOCUMENTS

<i>Y</i>	JP 11,133,353	1999-05-21	Sawai			
<i>Y</i>	JP 11,326,825	1999-11-26	Ichiro, et al.			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

<i>Y</i>		Jansson patent application entitled: Method, Program and Apparatus for Efficiently Removing Stray-Flux Effects by Selected-Ordinate Image Processing, see page 3 and exhibit y of application.
<i>Y</i>		"Scalpel: A Projection Electron-Beam Approach to Sub-Optical Lithograph", Liddle, Lloyd, et al., Bell Laboratories, Lucent Technologies, May 1999. PP. 1-71.
<i>Y</i>		"MIRCAM", Posselt, Winfried et al. PP. 1-10.
<i>Y</i>		"A Parallel Implementation of Collective Learning Systems Theory", Peter Bock, Department of Electrical Engineering and Computer Science. 1990. PP. 457-469.

Examiner

*Y. K.*

Date Considered

*8/18/04*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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<i>[initials]</i>	6,028,671	02/22/2000	Svetkoff, et al.	356	368	
<i>[initials]</i>	6,043,938	03/28/2000	Ogasawara	359	652	
<i>[initials]</i>	6,208,470 B1	03/27/2001	Anderson, et al.	359	649	
<i>[initials]</i>	6,213,606 B1	04/10/2001	Holman, et al.	353	20	
<i>[initials]</i>	6,220,713	04/24/2001	Tadic-Galeb, et al.	353	77	
<i>[initials]</i>	6,222,676 B1	04/24/2001	Togino, et al.	359	630	
<i>[initials]</i>	6,248,988 B1	06/19/2001	Krantz	250	201.3	
<i>[initials]</i>	6,280,035 B1	08/28/2001	Tadic-Galeb, et al.	353	31	

FOREIGN PATENT DOCUMENTS


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